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## PERFORMANCE SPECIFICATION SHEET

### PRINTED WIRING BOARD, FLEXIBLE, SINGLE AND DOUBLE LAYER, WITH OR WITHOUT PLATED-THROUGH HOLES, WITH OR WITHOUT STIFFENERS, FOR SOLDERED PART MOUNTING

This specification is approved for use by all Departments and Agencies of the Department of Defense.

The requirements for acquiring the product described herein shall consist of this specification sheet and [MIL-PRF-31032](#).

#### 1. SCOPE

1.1 Scope. This specification covers the generic performance requirements for flexible, single and double sided (one or two conductor layers) printed wiring boards (hereafter designated printed board) with or without plated holes and with or without stiffeners that will use soldering for component/part mounting (see [6.1.1](#)).

1.2 Classification. Printed boards covered by this specification are of the following types and installation uses.

1.2.1 Types. The printed board types are classified as follows, as specified (see [6.2](#)).

Type 1 – Single-sided flexible printed board.

Type 2 – Double-sided flexible printed board.

1.2.2 Installation uses. The installation uses following describe the possible usage/application of the printed boards (see [6.2.e](#)).

Use A – The flexible printed board is capable of withstanding flexing during installation (flex-to-install) (see [6.2.1.d](#)).

Use B – The flexible printed board is capable of withstanding continuous flexing (dynamic flex) for a number of cycles specified in the printed board procurement documentation (see [6.2.1.c](#)).

#### 2. APPLICABLE DOCUMENTS

2.1 General. The documents listed in this section are specified in sections [3](#), [4](#), or [5](#) of this specification. This section does not include documents cited in other sections of this specification or recommended for additional information or as examples. While every effort has been made to ensure the completeness of this list, document users are cautioned that they must meet all specified requirements of documents cited in sections 3, 4, or 5 of this specification, whether or not they are listed.

Comments, suggestions, or questions on this document should be addressed to DLA Land and Maritime, ATTN: VAC, P.O. Box 3990, Columbus, OH 43218-3990, or emailed to [5998.Documents@dla.mil](mailto:5998.Documents@dla.mil). Since contact information can change, you may want to verify the currency of this address information using the ASSIST Online database at <https://assist.dla.mil>.

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2.2 Government documents. The following specification forms a part of this document to the extent specified herein. Unless otherwise specified, the issues of these documents are those cited in the solicitation or contract.

DEPARTMENT OF DEFENSE SPECIFICATIONS

[MIL-PRF-31032](#) – Printed Circuit Board/Printed Wiring Board, General Specification for.

(Copies of these documents are available online at <https://assist.dla.mil/quicksearch> or <https://assist.dla.mil> or from the Standardization Document Order Desk, 700 Robbins Avenue, Building 4D, Philadelphia, PA 19111-5094.)

2.3 Non-Government publications. The following documents form a part of this document to the extent specified herein. Unless otherwise specified, the issues of the documents are those cited in the solicitation or contract.

ASTM INTERNATIONAL (ASTM)

- ASTM B567 – Standard Test Method for Measurement of Coating Thickness by the Beta Backscatter Method.
- ASTM B568 – Standard Test Method for Measurement of Coating Thickness by X-Ray Spectrometry.

(Application for copies should be addressed to the ASTM International, 100 Barr Harbor Drive, P. O. Box C700, West Conshohocken, PA 19428-2959 or <http://www.astm.org>.)

IPC - ASSOCIATION CONNECTING ELECTRONICS INDUSTRIES (IPC)

- IPC-2221 – Generic Standard for Printed Board Design.
- IPC-2223 – Sectional Design Standard for Flexible Printed Boards.
- IPC-A-600 – Acceptability of Printed Boards.
- [IPC-TM-650](#) – Test Methods Manual.
- IPC-9252 – Requirements for Electrical Testing of Unpopulated Printed Boards.
- J-STD-003 – Solderability Tests for Printed Boards.

(Application for copies should be addressed to IPC - Association Connecting Electronics Industries, 3000 Lakeside Drive, Suite 309 S, Bannockburn, IL 60015-1249 or <http://www.ipc.org>.)

(Non-Government standards and other publications are normally available from the organizations that prepare or distribute the documents. These documents also may be available in or through libraries or other informational services.)

2.4 Order of precedence. Unless otherwise noted herein or in contract, in the event of a conflict between the text of this document and the references cited herein, the text of this document takes precedence. Nothing in this document, however, supersedes applicable laws and regulations unless a specific exemption has been obtained.

3. REQUIREMENTS

3.1 Printed board detail requirements. Printed boards delivered under this specification shall be in accordance with the requirements as specified herein, and documented in the printed board procurement documentation.

3.1.1 Conflicting requirements. The order of precedence of conflicting requirements shall be in accordance with [MIL-PRF-31032](#).

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3.1.2 Reference to printed board procurement documentation. For the purposes of this specification, when the term "specified" is used without additional reference to a specific location or document, the intended reference shall be to the applicable printed board procurement documentation.

3.2 Qualification. Printed boards furnished under this specification shall be technologies that are manufactured by a manufacturer authorized by the qualifying activity for listing on the applicable qualified manufacturers list before contract award (see 4.2 and 6.3).

3.3 Design (see 3.1 and 6.2). Printed boards shall be of the design specified. Unless otherwise noted herein, if individual design parameters are not specified in the printed board procurement documentation, then the baseline design parameters shall be as specified as follows:

- a. Overall printed board design baseline shall be in accordance with IPC-2223, type 1 or type 2, performance class 3.
- b. Test coupon design, quantity, placement, and usage shall be in accordance with IPC-2221, performance class 3. Test coupons shall be as specified in the applicable design standard and shall reflect worst case design conditions of the printed boards that they represent.

3.4 Printed board materials. All materials used in the construction of compliant printed boards shall comply with the applicable specifications referenced in the printed board procurement documentation. If materials used in the production of printed boards are not specified, then it is the manufacturer's responsibility to use materials which will meet the performance requirements of this specification. Acceptance or approval of any printed board material shall not be construed as a guarantee of the acceptance of the completed printed board.

3.4.1 Prohibited materials (see 6.7). Unless otherwise specified, electroplated or immersion tin shall not be used as a finish either externally, internally, or as an undercoat. Electroplated or immersion tin is any tin or tin alloy containing more than 97 percent tin. If used as a finish, tin shall be alloyed with a minimum of three percent lead. The use of tin-lead (Sn-Pb) finishes is acceptable provided that the minimum lead content is three percent.

3.5 External visual and dimensional requirements. Printed board test specimens (the finished printed boards or supporting test coupons, as applicable) shall conform to the requirements specified in 3.5.1 through 3.5.7.2, as applicable. Scratches, dents, and tool marks shall not bridge or expose signal conductors, expose base metal, expose or disrupt reinforcement fibers, reduce dielectric properties, or reduce spacing below the minimum requirements herein. The figures, illustrations, and photographs contained in IPC-A-600 can aid in the visualization of externally observable accept/reject conditions of printed boards or test specimens.

3.5.1 Base material.

3.5.1.1 Edges of flexible base material. Base material edges include the external edge of the printed board, the edges of cutouts, and the edges of non-plated-through holes. The trimmed edge of completed printed boards shall be free of defects such as burrs, delaminations, nicks, or tears in excess of those allowed in 3.5.1.2 and 3.5.1.3. If no edge spacing requirement is specified, any base material edge defect shall not exceed 2.5 mm (.0984 inch). Following the solderability or resistance to soldering heat test, discolorations or resin recession at completed or trimmed edges of the flexible base material shall be acceptable provided that the discoloration or resin recession defect does not reduce the edge spacing below the specified requirements. Loose metallic burrs shall not be acceptable.

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3.5.1.2 Surface imperfections. Imperfections in the surface of the base material such as blistering, burrs, cuts, dents, exposed reinforcement material fibers, foreign materials, gouges, nicks, pits, resin scorched areas, resin starved areas, scratches, tool marks, variations in color such as white spots or black spots, or other visual defects detrimental to the performance of the base material shall be acceptable in localized concentrations providing the following conditions are met:

- a. The imperfections do not bridge between conductors.
- b. The dielectric spacing between the imperfection and a conductor is not reduced below the specified minimum conductor spacing requirements.

3.5.1.3 Surface pits and voids. Surface pits and voids in the base material shall be acceptable providing the following conditions are met:

- a. Surface pits or voids are no bigger than 0.8 mm (.031 inch) in the longest dimension.
- b. The surface pits or voids do not bridge conductors.
- c. The total area of all surface pits or voids does not exceed five percent of the total printed board area.
- d. The surface pit or void does not affect the performance of the base material.

3.5.1.4 Subsurface imperfections. Subsurface imperfections (such as blistering, delamination, foreign inclusions, and haloging) shall be acceptable providing the following conditions are met:

- a. The imperfections do not bridge more than 25 percent of the distance between access holes, conductors, or plated-through holes. No more than two percent of the printed board area on each side shall be affected.
- b. The imperfections do not reduce conductor or dielectric spacing below the specified minimum requirements.
- c. The imperfections do not propagate as a result of testing (such as rework simulation, resistance to soldering heat, or thermal shock).
- d. The longest dimension of any single imperfection is no greater than 0.80 mm (.031 inch). In non-circuitry areas, the maximum size shall not be greater than 2.00 mm (.079 inch) in the longest dimension or 0.01 percent of the printed board area, maximum.
- e. Following the solderability or resistance to soldering heat test, discoloration or resin recession shall be acceptable at access hole edges provided the criteria of 3.5.1.1 is met.

3.5.1.5 Measling and crazing. Unless otherwise specified, measling and crazing shall comply with the class 3 acceptable conditions of IPC-A-600.

### 3.5.2 Conductor pattern.

3.5.2.1 Bonding of conductor to base material and lifted lands. There shall be no peeling or lifting of any land or conductor patterns from the base material. The completed printed board shall not exhibit any lifted land. (NOTE: See 3.6.2.4 for allowances for the acceptable lifting of terminal pads, i.e. lifted lands, following the resistance to soldering heat test, rework simulation, and thermal shock testing.)

3.5.2.2 Conductor finish (plating or coating). The conductor finish shall be as specified.

3.5.2.2.1 Coverage. The conductor finish shall completely cover the exposed horizontal portion of the conductor pattern. Voids in the conductor finish coverage of plated-through hole walls shall comply with the requirements herein (see 3.5.2.2.2). Complete coverage does not apply to the vertical conductor edges.

3.5.2.2.2 Conductor finish plating and coating voids in plated-through holes. The conductor finish plating and coating shall not have voids that exceed the following limits:

- a. No more than one final finish void in any plated-through hole.
- b. Not more than five percent of the plated-through holes shall have final finish voids.
- c. Any final finish void present is not more than five percent of the plated-through holes length.
- d. Any final finish void present is less than 90 degrees of the circumference of the plated-through hole.

3.5.2.2.3 Dewetting. For tin alloys, reflowed tin-lead, or solder coated surfaces, a maximum of five percent of dewetting is permitted on any conductive surface where a solder connection will be required. Dewetting on conductors, ground, or voltage planes not used for solder connections shall meet the requirements of [J-STD-003](#).

3.5.2.2.4 Nonwetting. For tin alloys, reflowed tin-lead, solder coated surfaces, nonwetting is not permitted on any conductive surface where a solder connection will be required. Absence of solder on the vertical sides of lands shall be acceptable.

3.5.2.2.5 Plating junctions. Unless otherwise specified, the following requirements apply to all junctions of different plating or coating materials:

- a. There shall be no exposed copper in the junction of metallic platings or coatings.
- b. An overlap of metallic platings or coatings shall be acceptable if it is no greater than 0.8 mm (.031 inch) in length.
- c. When both solder coating and gold plating are present at a plating junction, a discolored or gray-black area at that plating overlap zone shall be acceptable.

3.5.2.2.6 Thickness (non-destructive). The plating or coating thickness of the conductor finish shall be as specified.

3.5.2.2.7 Whiskers. There shall be no whiskers of solder or other platings on the surface of the conductor pattern.

3.5.2.3 Conductor imperfections. The conductor pattern shall contain no cracks, splits, or tears. Unless otherwise specified, any combination of edge roughness, nicks, pinholes, cuts or scratches exposing the base material shall not reduce each conductor width by more than 20 percent of its minimum specified width. There shall be no occurrence of the 20 percent reductions greater than 13.0 mm (.51 inch) or 10 percent of a conductor length, whichever is less.

3.5.2.3.1 Cuts and scratches. A scratch of any length or width is permissible on ground or voltage planes, provided the dielectric is not exposed. Scratches on non-critical conductors may be of any length, but no deeper than 20 percent of the total conductor thickness.

3.5.2.3.2 Dents. A dent of any length or width on ground planes shall be acceptable provided the clad surface is not torn. Dents on conductive patterns may be of any length, but no deeper than 0.013 mm (.0005 inch).

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3.5.2.3.3 Pinholes. Pinholes in ground or voltage planes in non-critical areas shall be acceptable provided they have no single diameter greater than 0.5 mm (.0197 inch) and do not exceed three for each 25 mm (.984 inch) diameter. A pinhole in a conductive pattern shall be acceptable, provided it does not reduce the width of a conductive pattern by 10 percent. Pinholes shall be limited to no more than one for each 25 mm (.984 inch) of conductive length.

3.5.2.3.4 Pits. Pits in ground or voltage planes shall be acceptable provided they do not exceed 25 percent of the surface area. Any pit in the conductive pattern is acceptable provided the outline dimension does not exceed 10 percent of the conductor width, and there is no more than one pit for each 25 mm (.984 inch) of the conductor length.

3.5.2.3.5 Superfluous metal. Unless otherwise specified, small particles of metal such as extraneous copper or subsequent plating after etching, which remain affixed to areas that are intended to be free of conductive material, shall be acceptable providing the following conditions are met:

- a. The superfluous metal is no closer than 6.4 mm (.25 inch) to any conductor.
- b. The superfluous metal is smaller than 0.13 mm (.005 inch) at its greatest diameter.

3.5.2.4 Conductor width and spacing.

3.5.2.4.1 Conductor spacing. Conductor spacing shall be as specified.

3.5.2.4.2 Conductor width. Conductor width shall be as specified. (NOTE: See 3.5.2.3 for allowances for the acceptable reduction of the specified conductor width.)

3.5.2.5 Lands for component mounting. The lands to be used for component mounting shall be as specified. Imperfections on annular rings, surface mount lands, or wire bond pads shall be acceptable provided they do not exceed the defect requirements specified herein.

3.5.2.5.1 Component hole lands. The external annular ring for component hole lands shall be as specified. Unless otherwise specified, the external annular ring may have in isolated areas a 20 percent reduction of the specified minimum external annular ring due to defects such as pits, dents, nicks, pinholes, and coverlayer (see 3.5.3.1) or stiffener (see 3.5.5) access hole misregistration. No more than 20 percent of the annular ring circumference (72 degrees) may be affected.

3.5.2.5.1.1 Adhesive on lands of solderable plated-through holes. Unless otherwise specified, the minimum external annular ring for solderable plated-through holes shall not be reduced by more than 10 percent due to adhesives extruded onto lands.

3.5.2.5.1.2 Adhesive on lands of unsupported holes. Unless otherwise specified, the minimum external annular ring for solderable unsupported holes shall not be reduced by more than 33 percent due to adhesives extruded onto lands.

3.5.2.5.2 Rectangular surface mount lands (see figure 1). Defects such as nicks, dents, and pin holes along the external edge of the land shall not exceed 20 percent of either the length or width of the land and shall not encroach the pristine area, which is defined by the central 80 percent of the land width by 80 percent of the land length as shown on figure 1. Defects internal to the land shall not exceed 10 percent of the length or width of the land and shall remain outside of the pristine area of the surface mount land. One electrical test probe witness mark shall be acceptable within the pristine area.

3.5.2.5.3 Round surface mount lands (ball grid array [BGA] lands) (see figure 2). Defects such as nicks, dents, and pin holes along the edge of the land shall not radially extend towards the center of the land by more than 10 percent of the diameter of the land and shall not extend more than 20 percent around the circumference of the land as shown on figure 2. There shall be no defects within the pristine area which is defined by the central 80 percent of the land diameter. One electrical test probe witness mark shall be acceptable within the pristine area.

3.5.2.5.4 Wire bond lands. Unless otherwise specified, the maximum conductor finish roughness (surface roughness) for pads or areas designated for wire bonding shall be no greater than 0.8 micrometers (31 micro inches). Unless otherwise specified, the wire bond land bonding area shall be defined as the pristine area as shown on figure 1 for rectangular pads or on figure 2 for round pads. There shall be no pits, nodules, scratches, electrical test probe witness marks, or other defects in the pristine area that exceed the surface roughness limits.

3.5.2.6 Holes for interlayer connections. The external annular ring of holes used for interlayer connections shall be as specified. Unless otherwise specified, the external annular ring may have in isolated areas a 20 percent reduction of the specified minimum external annular ring due to defects such as dents, pinholes, pits, or nicks.

3.5.2.7 Conductor thickness (single sided) (non-destructive). The conductor thickness on printed boards shall be as specified. Unless otherwise specified, the minimum final conductor thickness (metal foil) shall not be reduced by more than 10 percent for deposited metal foil types or 5 percent for wrought or rolled metal foil types, from the starting metal foil nominal thickness as converted from the area weight of the foil.

### 3.5.3 Coverlayer.

3.5.3.1 Access hole registration. The coverlayer registration shall be such that the size or diameter of the access hole shall not reduce the component land area or minimum annular ring below the limits specified (see 3.5.2.5.1). Misregistration of the coverlayer shall not expose adjacent isolated conductors or lands.

3.5.3.2 Delamination. There shall be no coverlayer delamination along the outer edges of the coverlayer. Coverlayer delamination shall be acceptable providing the following conditions are met:

- a. At random locations away from conductors if each delamination is no larger than 6.45 square mm (.010 square inch) and is not within 1.0 mm (.04 inch) of the printed wiring board edge or an access hole edge. The total number of the above delaminations shall not exceed three in any 645 square mm (1.0 square inch) of coverlayer surface area.
- b. Along conductor edges, the total delamination does not exceed either 0.05 mm (.02 inch) in width or 20 percent of the spacing between adjacent conductors, whichever is smaller.

3.5.3.2.1 Delamination after flexibility endurance or folding flexibility testing. After exposure to the flexibility endurance test (see 3.7.4.4 and 4.7.4.4) or folding flexibility test (see 3.7.4.5 and 4.7.4.5), there shall be no propagation of any coverlayer delamination in the flex area.

3.5.3.3 Solder wicking. Wicking of solder under the coverlayer shall be acceptable provided the conductor spacing requirements are met.

3.5.3.4 Wrinkles or creases. Wrinkles or creases in the coverlayer shall be acceptable provided the requirements of 3.5.3.2 are met.

3.5.4 Dimensional (interface and physical dimension) requirements. The completed printed board shall meet the interface and physical dimensions requirements specified. The dimensional requirements include items such as the conductor pattern including component lands and terminals, cutouts, overall board thickness, periphery, and other design features as specified. In the event that a dimensional characteristic is not specified, the applicable class 3 of IPC-2221 design default for that characteristic shall apply.

3.5.4.1 Conductor pattern feature accuracy. Conductor pattern feature accuracy shall be as specified.

3.5.4.2 Hole pattern accuracy. The location of the hole pattern in the printed board shall be as specified.

3.5.4.3 Hole size. The hole size and tolerance shall be as specified. Unless otherwise specified, hole size tolerance shall be applied after plating. Nodules or rough plating in plated-through holes shall not reduce the hole diameter below the minimum limits specified.

3.5.4.4 Edge board contacts edge condition. The end or beveled edge of edge board contacts shall be smooth with no burrs, roughness, or lifted plating. There shall be no separation of the edge board contacts from the base material or any loose reinforcement fibers on the beveled edge. Exposed copper on the end or beveled edge of the edge board contact shall be acceptable. Conductor finish plating or coating shall comply with the requirements of 3.5.2.2.

3.5.5 Stiffeners (see 6.6). The design, placement and acceptability requirements for stiffeners shall be as specified.

3.5.6 Stiffener access hole registration. Stiffener access hole registration shall be such that the size or diameter of the access hole shall not reduce the component land area or minimum annular ring below the limits specified (see 3.5.2.5).

3.5.7 Via protection.

3.5.7.1 Filled via, resin, cap plating (see figure 3). When the design requires the copper cap plating of filled vias (see 3.1), all vias required to be protected by cap plating shall be completely covered by the cap plating. The plated copper surface shall be planar with no indication of the filled via underneath. Visually discernable protrusions (bumps) and depressions (dimples) in the copper plating over filled vias shall be acceptable providing they meet the requirements of 3.6.5. Voids in the copper cap plating over the filled portion of the via shall not be acceptable.

3.5.7.2 Unfilled via, solder mask tenting (see figure 4). When the design requires the tenting of solder mask over unfilled vias (see 3.1), all vias required to be protected shall be completely covered by solder mask. Voids in the solder mask over the via exposing the hole shall not be acceptable.

3.6 Microsection requirements (double sided with plated holes only). Printed board test specimens (production printed boards or test coupons) shall conform to the requirements in 3.6.1 through 3.6.5.2, as applicable. Barrel cracks, butt plating joints, circumferential separations, corner cracks, and cracked copper plating shall not be acceptable. IPC-A-600 contains figures, illustrations, and photographs that can aid in the visualization of internally observable accept/reject conditions of microsectioned test specimens. If a condition is not addressed herein, or specified on the printed board procurement documentation, it shall comply with the class 3 criteria of IPC-A-600.

3.6.1 Base material. Unless otherwise specified, the following base material acceptance criteria shall apply.

3.6.1.1 Adhesive voids. Adhesive voids (when applicable) in the flexible metal clad base material shall not be greater than 0.5 mm (.02 inch) or 25 percent of conductor spacing, whichever is less, shall be acceptable.

3.6.1.2 Dielectric layer thickness. The minimum dielectric thickness between conductor layers shall be as specified.

3.6.1.3 Laminate voids (see figure 5). Laminate voids with the longest dimension of 0.08 mm (.003 inch) or less shall be acceptable provided the conductor spacing is not reduced below the minimum dielectric spacing requirements, laterally or vertically, as specified. For type 2 designs, after undergoing rework simulation (see 3.7.4.5), resistance to soldering heat (see 3.7.6.2), or thermal shock (see 3.7.6.3), laminate voids are not evaluated in zone A.

### 3.6.2 Conductor pattern.

3.6.2.1 Conductor finish thickness (plating or coating). The plating or coating thickness of the conductor finish shall be as specified.

3.6.2.2 Conductor thickness (double sided with plating). The conductor thickness on printed boards shall be as specified. When a conductor thickness with tolerance is specified, the external conductor thickness shall be within the specified tolerance for the specified thickness. For wrought or rolled metal foil types, if only a starting metal foil weight is specified, the minimum final conductor thickness (metal foil or metal foil and plating, as applicable) shall not be reduced by more than 5 percent from the nominal starting metal foil thickness as converted from the area weight of the foil. For deposited metal foil types, if only a copper foil weight requirement is specified (no conductor thickness is specified), the limits for external layer foil thickness after processing defined in the External Conductor Thickness After Plating table of [IPC-2221](#) shall apply.

3.6.2.3 Conductor width. The conductor width shall be as specified (see [3.1](#)).

3.6.2.4 Lifted lands (after rework simulation, resistance to soldering heat, or thermal shock) (see figure 5). After undergoing rework simulation (see [3.7.4.6](#)), resistance to soldering heat (see [3.7.6.2](#)) or thermal shock (see [3.7.6.3](#)), the maximum allowed lifted land distance from the printed board surface plane to the outer lower edge of the land shall be the thickness (height) of the terminal area or land. The completed, non-stressed printed board shall not exhibit any lifted lands.

3.6.3 Plated-through hole plating. Unless otherwise specified, copper plating thickness applies to the hole wall, the hole knee, and the surface land of the plated-through hole.

3.6.3.1 Copper plating defects. Nodules, plating folds, plating inclusions, or plated reinforcement material protrusions that project into the plated-through hole shall be acceptable provided that the hole diameter and the copper thickness are not reduced below their specified limits.

3.6.3.2 Copper plating thickness. Unless otherwise specified, the copper plating thickness shall be in accordance with the applicable design standard. Any copper plating thickness less than 80 percent of the specified thickness shall be treated as a void.

3.6.3.2.1 Copper plating voids. The copper plating in the plated-through hole shall not exhibit any void in excess of the following:

- a. There shall be no more than one plating void for each panel, regardless of length or size.
- b. There shall be no plating void longer than five percent of the total printed board thickness.

Conductor finish plating or coating material between the base material and copper plating (i.e., behind the hole wall copper plating) is evidence of a void. Any plated-through hole exhibiting this condition shall be counted as having one void for panel acceptance purposes.

3.6.3.2.2 Wrap copper plating. Unless otherwise specified, the wrap plating (plated-through hole surface and knee continuous copper plating) thickness shall be as specified. The wrap plating shall not be reduced by more than 50 percent of the specified wrap copper plating thickness due to planarization or other processing.

3.6.3.3 Conductive interface separations. Except for along the vertical edge of the external copper foil, there shall be no separations or contamination between the hole wall conductive interfaces. Conductive interface separations along the vertical edge of the external copper foil shall be acceptable. Anomalies resulting from this separation shall not be cause for rejection.

NOTE: The term conductive interfaces shall be used to describe the junction between the hole wall plating or coating and the surfaces of internal and external layers of copper or metal foil. The interface between platings and coating (electroless copper, direct metallization copper, nonmetallic conductive coatings, or vacuum deposited copper, as applicable, and electrolytic copper, whether panel or pattern plated), shall also be considered a conductive interface.

3.6.3.4 Wicking. Wicking of copper plating extending 0.08 mm (.003 inch) into the base material shall be acceptable provided it does not reduce the conductor spacing below the minimum clearance spacing requirements specified.

3.6.4 Metallic cracks. There shall be no cracks in the platings or coatings. For terminal or land areas plated with copper, cracks are permissible in the external layer (outer) copper foil provided they do not extend or propagate into the plated copper.

### 3.6.5 Via cap plating.

3.6.5.1 Thickness. For designs that specify copper plating for via protection, the minimum via cap plating thickness over filled vias shall be as specified (see 3.1).

3.6.5.2 Cap plating imperfections. When cap plating of a filled via is specified (see 3.1), voids in the plating over the via fill shall not be acceptable. Separation of the via cap plating to via fill material shall be acceptable. Separation of the via cap plating to underlying plating shall not be acceptable. Depressions (dimples) below the surface of the land shall be no greater than 0.08 mm (.003 inch). Protrusions (bumps) of the cap plating above the surface of the land shall be no greater than 0.05 mm (.002 inch).

3.7 Performance requirements. The performance requirements specified in 3.7.1 through 3.7.6.4 shall be verified by the test methods detailed in 4.7. Unless otherwise specified by the Technical Review Board (TRB), test optimization in accordance with MIL-PRF-31032 may be used, but the printed boards shall meet all of the performance requirements specified and herein, regardless of the verification method used.

3.7.1 Acceptability (of printed boards). When examined as specified in 4.7.1, the printed boards shall be in accordance with the acceptance requirements specified in 3.3 (design), 3.4 (material), 3.5 (external visual and dimensional), 3.8 (marking), and 3.9 (workmanship).

3.7.2 Destructive physical analysis (DPA) by microsectioning and evaluation of printed board test specimens. When printed board test specimens (completed printed boards, supporting test coupons, or qualification test specimens) are microsectioned and examined as specified in 4.7.2, the requirements specified in 3.1, 3.3, and 3.6 shall be met. Microsections of non-stressed printed board test specimens shall be evaluated when the microsection examination of the stressed printed board test specimens suggest that a failure condition may exist in the completed boards (prior to being subjected to resistance to soldering heat testing).

### 3.7.3 Chemical requirements.

3.7.3.1 Ionic contamination (cleanliness) (when specified, see 6.2.1.a and 6.5.1). When printed board test specimens are tested in accordance with 4.7.3.1, the levels of ionic contamination for completed printed boards shall be as specified.

3.7.3.2 Copper plating characteristics.

3.7.3.2.1 Elongation. When copper plating is tested in accordance with 4.7.3.2, the elongation shall be 12 percent minimum.

3.7.3.2.2 Tensile strength. When copper plating is tested in accordance with 4.7.3.3, the tensile strength shall be 248 MPa (36,000 psi) minimum.

3.7.4 Physical requirements.

3.7.4.1 Adhesion, marking. After marking is tested in accordance with 4.7.4.1, any specified markings which are missing in whole or in part, faded, shifted (dislodged), or smeared to the extent that it cannot be readily identified or is not legible shall constitute failure. A slight change in the color of ink or paint markings after the test shall be acceptable.

3.7.4.2 Adhesion, plating. When tested as specified in 4.7.4.2, there shall be no part of the conductor pattern or copper plating protective finish (coating or plating) removed from the printed board test specimen except for those related to outgrowth, overhang, or slivers.

3.7.4.3 Bow and twist (designs with stiffeners and bow and twist limits only)(when specified, see 6.2.1.b and 6.5.2). When printed boards are tested as specified in 4.7.4.3, the maximum limit for bow and twist shall be as specified.

3.7.4.4 Flexibility endurance (use B only). When tested as specified in 4.7.4.4, the printed board test specimen shall be capable of withstanding the specified conditions of 3.7.4.4.1 or 3.7.4.4.2, as applicable, without any evidence of damage, degradation or rejectable delamination. After the test, the requirements specified in 3.7.5.1 and 3.7.5.2 shall be met.

3.7.4.4.1 Qualification and periodic testing. A single sided (type 1) printed wiring board test specimen shall be capable of withstanding 100,000 cycles.

3.7.4.4.2 Acquiring activity specified (see 6.2.1.c). The test specimen shall be capable of withstanding the flexing for the number of flexing cycles, flexing rate, and points of application specified.

3.7.4.5 Folding flexibility. When tested as specified in 4.7.4.5, printed board test specimen shall be capable of withstanding the specified conditions of 3.7.4.5.1 or 3.7.4.5.2, as applicable, without any evidence of damage, degradation or rejectable delamination. After the test, the requirements specified in 3.5.3, 3.7.5.1, and 3.7.5.2 shall be met.

3.7.4.5.1 Qualification and periodic testing. The baseline folding flexibility parameters for qualification and periodic testing shall be as follows:

- a. Direction of bend: Both directions (top and bottom).
- b. Degree of bend: 180 degrees.
- c. Point of application: Center of test specimen.
- d. Diameter of mandrel: Twelve times overall material thickness, reduced to the nearest 2.50 mm (.098 inch).
- e. Number of fold cycles: 25.

3.7.4.5.2 Acquiring activity specified (see 6.2.1.d). The test printed board specimen shall be capable of withstanding the folding for the direction of bend, degree of bend, points of application, number of fold cycles, and diameter of mandrel specified.

3.7.4.6 Rework simulation.

3.7.4.6.1 For printed boards with unsupported holes only. After undergoing the test specified in 4.7.4.6.1, the printed board test specimens with unsupported holes shall withstand 2.27 Kg (5 pounds) pull or 3.45 MPa (500 pounds per square inch), whichever is less.

3.7.4.6.2 For printed boards with plated holes. After undergoing the test specified in 4.7.4.6.2, the printed board test specimens shall be microsectioned and inspected in accordance with 4.7.2 and the requirements specified in 3.6 shall be met.

3.7.4.7 Solderability (see 6.2.1.e). Printed board designs that do not require soldering to attach components (as in the case where press-fit components or wire bonding are used) do not require solderability testing. Printed boards that require soldering during assembly processes require solderability testing. Printed boards using only surface mount component do not require hole solderability testing. When required by the procurement documentation, accelerated conditioning for coating durability shall be in accordance with J-STD-003. The default category of coating durability of J-STD-003 is category 2.

3.7.4.7.1 Hole solderability. After undergoing the test specified in 4.7.4.7, the printed board test specimen shall conform to the class 3 acceptance criteria specified in J-STD-003.

3.7.4.7.2 Surface solderability. After undergoing the test specified in 4.7.4.7, the printed board test specimen shall conform to the class 3 acceptance criteria specified in J-STD-003.

3.7.5 Electrical requirements. If specified (see 3.1), the use of indirect testing by signature comparison for continuity and isolation may be used for production screening.

3.7.5.1 Continuity (when specified, see 6.2.1.d). When tested in accordance with 4.7.5.1, the resistance between the endpoints of conductor patterns within a network of conductors shall be as specified (see 3.1). If no resistance limit is specified, there shall be no circuit whose resistance exceeds 10 ohms. For referee purposes, 0.5 ohm maximum for each 25.0 mm (.98 inch) of circuit length shall apply. Conductor patterns that consist of long runs of narrow conductors or short runs of very wide conductors may increase or decrease the resistance. The acceptability of these type of circuit patterns, of controlled impedance nets, or of embedded resistive patterns shall be as specified.

3.7.5.2 Isolation (when specified, see 6.2.1.d). When tested as specified in 4.7.5.2, the insulation resistance between mutually isolated conductors shall be specified (see 3.1). Unless otherwise specified, for production printed boards, the insulation resistance shall be greater than 100 megohms

3.7.6 Environmental requirements.

3.7.6.1 Moisture and insulation resistance. When tested as specified in 4.7.6.1, the printed board test specimen shall have a minimum of 500 megohms of resistance between conductors. After the test, the printed board test specimen shall not exhibit blistering or delamination in excess of that allowed in 3.5.1, 3.5.2, and 3.5.3.

3.7.6.2 Resistance to soldering heat.

3.7.6.2.1 Solder float thermal stress.

3.7.6.2.1.1 Type 1. After undergoing the test specified in 4.7.6.2.1, the printed board test specimen shall be inspected in accordance with 4.7.1 and not exhibit any cracking or separation of plating or conductors, terminals or lands shall not lift in excess of that allowed in 3.6.2.4, and shall meet the requirements of 3.5.1 and 3.5.3, inclusive.

3.7.6.2.1.2 Type 2. After undergoing the test specified in 4.7.6.2.1, the printed board test specimen shall be inspected in accordance with 4.7.1 and shall meet the requirements of 3.5.1 and 3.5.3, inclusive. The printed board test specimen shall then be microsectioned and inspected in accordance with 4.7.2 and shall meet the requirements of 3.1, 3.3, and 3.6.

3.7.6.2.2 Convection air oven solder reflow thermal stress. After undergoing the test specified in 4.7.6.2.2, the printed board test specimen shall be inspected in accordance with 4.7.2 and shall meet the requirements of 3.1, 3.3, and 3.6.

3.7.6.3 Thermal shock. After undergoing the test specified in 4.7.6.3, the printed board test specimens shall meet the following requirements:

- a. Visual inspection: When inspected as specified in 4.7.1, there shall be no evidence of plating cracks, blistering, crazing, or delamination in excess of that allowed in 3.5.
- b. Resistance change: The change in resistance between the first high temperature cycle and the last high temperature cycle shall not be more than 10 percent.
- c. DPA by microsection (double side with plated hole only): The printed board test specimen shall be vertically cross sectioned and inspected in accordance with 4.7.2 and the requirements specified in 3.1, 3.3, and 3.6 shall be met.

3.7.6.4 Temperature cycling.

3.7.6.4.1 Direct current induced. After undergoing the test specified in 4.7.6.4.1, the printed board test specimens shall meet the requirements of 3.5: For capability verification inspection testing, the following conditions shall apply:

- a. Number of samples: Six.
- b. Test temperature: 150 degrees Celsius.
- c. Resistance change: Ten percent.
- d. Maximum number of cycles: 250 for each 24 hour period.
- e. Data collection frequency: Ten cycles.
- f. Cooling ratio: 0.66.
- g. Table selection: System.

### 3.8 Marking.

3.8.1 Product identification and traceability. Product identification and traceability marking shall be in accordance with MIL-PRF-31032.

3.8.2 Marking legibility. After any, or all tests, marking that is either etched, screened, or ink stamped shall comply with the class 3, acceptable conditions detailed in IPC-A-600.

3.9 Workmanship. Printed boards shall be processed in such a manner as to be uniform in quality and shall be free from defects that will affect life, serviceability, or appearance.

## 4. VERIFICATION

4.1 Classification of inspections. The inspection requirements specified herein are classified as follows:

- a. Qualification inspection (see 4.2).
- b. Conformance inspection (see 4.3 and tables I and II).
- c. Capability verification inspection (see 4.6).

4.1.1 Sampling and inspection. Sampling and inspection shall be in accordance with MIL-PRF-31032, and as specified herein.

4.1.2 Standard test and inspection conditions. Unless otherwise specified by the applicable test method or procedure, inspections and tests may be performed at ambient conditions.

4.2 Qualification inspection. Unless otherwise specified by the TRB approved qualification test plan, qualification inspection shall be in accordance with MIL-PRF-31032 and as specified herein.

4.2.1 Qualification test vehicles. The qualification test vehicle(s) to be subjected to qualification inspection shall be in accordance with the TRB approved qualification test plan and the applicable qualification test vehicle specification(s).

4.2.1.1 Sample. The number of qualification test vehicle(s) to be subjected to qualification inspection shall be in accordance with TRB approved qualification test plan.

4.2.2 Test routine. The qualification test vehicle(s) shall be subjected to the inspections and tests specified in tables I and II in addition to thermal shock in accordance with 3.7.6.3 and 4.7.6.3.

4.2.3 Qualification by similarity. A production lot may be considered qualified by similarity if the dimensional parameters are within twenty-five percent of those currently qualified and the processing steps used are a set or subset of those processes used for a previous qualified technology. When producing printed board designs that are within the 25 percent dimensional parameter region of a qualified process but exceed the currently qualified process limits, the TRB shall review and approve the new process limits.

4.3 Conformance inspection. Conformance inspection shall be in accordance with MIL-PRF-31032 and shall consist of lot conformance inspection (see 4.4) and periodic conformance inspection (see 4.5).

4.4 Lot conformance inspection. Lot conformance inspection shall be in accordance with MIL-PRF-31032 and table I herein. Panels, pallets, and printed boards to be delivered in accordance with this specification shall have been subjected to and passed all applicable inspections and tests of table I prior to delivery of product. Lot conformance inspection testing by subgroup or within a subgroup may be performed in any sequence.

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TABLE I. Lot conformance inspection.

Inspection	Requirement paragraph	Method paragraph	Specimen to test <u>1/</u>				Sample plan <u>2/</u>
			B/P	THM	SMT	MIX	
Subgroup 1 Solder float thermal stress	<a href="#">3.7.6.2</a>	<a href="#">4.7.6.2</a>		A and B	A and B	A and B	Plan TJ
Subgroup 2 External visual and dimensional acceptability	<a href="#">3.7.1</a>	<a href="#">4.7.1</a>	X				Plan BF or TJ <u>3/</u> <u>4/</u>
Subgroup 3 Chemical: Ionic contamination	<a href="#">3.7.3.1</a>	<a href="#">4.7.3.1</a>	<u>5/</u>				See <u>5/</u>
Subgroup 4 Physical: Adhesion, marking Adhesion, plating Bow and twist Solderability Hole Surface	<a href="#">3.7.4.1</a> <a href="#">3.7.4.2</a> <a href="#">3.7.4.3</a> <a href="#">3.7.4.7.1</a> <a href="#">3.7.4.7.2</a>	<a href="#">4.7.4.1</a> <a href="#">4.7.4.2</a> <a href="#">4.7.4.3</a> <a href="#">4.7.4.7</a> <a href="#">4.7.4.7</a>	X X X	<u>6/</u> C S or A	<u>6/</u> C C or M	<u>6/</u> C A or S C or M	Plan BH or TJ <u>7/</u> Plan BH or TJ <u>7/</u> <u>8/</u> See <u>5/</u> See <u>9/</u> Plan TJ
Subgroup 5 Electrical: Continuity Isolation resistance	<a href="#">3.7.5.1</a> <a href="#">3.7.5.2</a>	<a href="#">4.7.5.1</a> <a href="#">4.7.5.2</a>	X X				Plan BH <u>10/</u> Plan BH <u>10/</u>

- 1/ Test coupons are in accordance with [IPC-2221](#). B/P is either a production printed board separated from the panel, a pallet of boards, or a partial or whole production panel of printed boards; THM is a through-hole mount test coupon; SMT is a surface mount test coupon; MIX is for printed board designs containing both through-hole and surface mount components test coupon.
- 2/ See [MIL-PRF-31032](#) for C = 0 sampling plans. See [4.4.1.1](#) for explanation of codes.
- 3/ Surface imperfections ([3.5.1.2](#)) and subsurface imperfections ([3.5.1.3](#)) shall be inspected prior to solder mask application.
- 4/ See [4.4.1.1.1](#) for test specimen selection options.
- 5/ When specified by acquiring activity (see [3.1](#) and [6.5](#)). See appropriate paragraph for acceptance criteria and sampling requirements.
- 6/ See [4.7.4.1](#) for test specimen description and quantity.
- 7/ Test coupon, partial or whole production panel, pallet, or production printed board, manufacturer option.
- 8/ All surface platings or coatings shall be inspected.
- 9/ For designs containing plated holes (see [4.4.1.1.2](#)).
- 10/ At the acquiring activity's option, for designs that will have only connector joined to the completed assembly, electrical testing can be performed at the assembly level (see [6.2.1.f](#)).

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4.4.1 Sample inspections. Panels and printed boards to be delivered in accordance with this specification shall have been subjected to and passed all the inspections of [table I](#), subgroups 1, 2, 3, 4, and 5.

4.4.1.1 Sampling. Samples shall be randomly selected from each inspection lot through the use of the C=0 sample plan in accordance with appendix E of [MIL-PRF-31032](#). The lot conformance inspection sample plan uses a two-character designator that identifies the inspection specimen (first letter) and the sample size series (second letter). The letter "B" is used as the first letter when pallets or production printed boards are to be sampled in their deliverable form. The letter "T" is used as the first letter when test vehicles (test coupons or partial or whole production panels) are to be sampled based on the number of panels in the lot. The second letter of the two-character designator uses the letters "H", "J", and "N" to identify the sample size series. The sample size series identifies the number to sample based on the lot size.

4.4.1.1.1 Panels and pallets. When a verification is performed when the printed boards are still on either a partial or whole production panel, the number to be sampled shall be the number of production panels in the lot, not the number of printed boards on the production panel. When the deliverable item is a pallet (or array) of printed boards, the number to be used for sampling is the number of pallets in the lot, not the number of printed boards on the pallet.

4.4.1.1.2 Hole solderability test coupons. When using the "S" test coupon, the number of samples to be tested shall be based on a statistical sample of the inspection panels in the lot using plan T.J. When using the "A" test coupon, the number of samples to be tested shall be based on the same statistical sample as the "S" test coupon, but a multiple of 4 shall be applied to the resulting sample size. The "A" test coupons shall be selected in groups of 4, taken from the same inspection panel.

4.4.1.2 PDA limits. When 100 percent of a production lot is inspected, either in lieu of sampling or due to rejection of a sample inspection lot, the PDA limits for this 100 percent inspection shall be 50 percent.

4.5 Periodic conformance inspection. Periodic conformance inspection shall be in accordance with TRB approved periodic conformance inspection plan or [table II](#) herein.

TABLE II. Periodic conformance inspection baseline test coverage.

Inspection	Requirement paragraph	Method paragraph	Frequency
Elongation <u>1/</u> Tensile strength <u>1/</u>	<a href="#">3.7.3.2.1</a> <a href="#">3.7.3.2.2</a>	<a href="#">4.7.3.2</a> <a href="#">4.7.3.3</a>	Monthly Monthly
Flexibility endurance <u>2/</u> Folding flexibility <u>2/</u>	<a href="#">3.7.4.4</a> <a href="#">3.7.4.5</a>	<a href="#">4.7.4.4</a> <a href="#">4.7.4.5</a>	Annually Annually
Rework simulation <u>2/</u> Moisture and insulation resistance <u>2/</u>	<a href="#">3.7.4.6</a> <a href="#">3.7.6.1</a>	<a href="#">4.7.4.6</a> <a href="#">4.7.6.1</a>	Monthly Monthly

1/ A minimum of ten test specimens (five lengthwise and five crosswise) shall be inspected.

2/ A minimum of two test specimens for each inspection.

4.6 Capability verification inspection. Capability verification inspection shall be in accordance with the TRB approved capability verification inspection plan. The frequency of this verification shall be as a minimum every 2 years. Each base material type qualified shall be verified. The following tests and inspections should be considered when accomplishing capability verification inspection: Thermal shock (see [3.7.6.3](#) and [4.7.6.3](#)), convection air oven solder reflow thermal stress (see [3.7.6.2.2](#) and [4.7.6.2.2](#)) and direct current induced thermal cycling (see [3.7.6.4](#) and [4.7.6.4](#)).

4.7 Methods of inspection.

4.7.1 Visual and dimensional inspection.

4.7.1.1 Visual inspection. The visual features of the printed board specimen shall be inspected in accordance with test method number [2.1.8 of IPC-TM-650](#), except that the magnification shall be 1.75x (3 diopters), minimum. If confirmation of a suspect defect cannot be determined at 1.75X, it shall be verified at progressively higher magnifications, up to 30X.

4.7.1.2 Dimensional inspection. The dimensional features of the printed board test specimen shall be inspected using test method numbers [2.2.1 and 2.2.2 of IPC-TM-650](#), as applicable. Referee inspection needed to confirm a suspected defect of the printed board test specimen features shall be accomplished at a magnification of up to 30X, as applicable to confirm the suspected defect.

4.7.1.3 Alternate plating and coating measurement techniques. When a conductor surface finish plating or coating thickness is less than 0.00125 mm (.00005 inch), the thickness measurements shall be performed in accordance with one of the following procedures:

- a. [ASTM B567](#), measurement of thickness by the beta backscatter method.
- b. [ASTM B568](#), measurement of thickness by X-ray spectrometry.

4.7.2 DPA by microsection evaluation (double sided).

4.7.2.1 Microsection preparation. Microsection preparation shall be accomplished by using methods in accordance with either test method numbers [2.1.1 or 2.1.1.2 of IPC-TM-650](#). Automatic microsectioning techniques may be used in lieu of IPC-TM-650 methods. The following details shall apply:

- a. Number of holes for each specimen. A minimum of at least three plated holes cross sectioned vertically shall be made for each test specimen required. Each side of the three plated holes shall be viewed independently. If more than three plated holes are in a row on a test specimen, as with the A/B coupon design, all plated holes in the row shall be evaluated.
- b. Accuracy. The plated holes to be evaluated on each test specimen shall be sectioned, ground, and polished to within  $\pm 10$  percent of the center of the drilled diameter of the hole.
- c. Pre-microetch evaluations. The plated holes shall be evaluated for plating separations prior to microetching.
- d. When more than two test specimens are contained in a mount (coupon-stacking or gang mounting), the following shall apply:
  - (1) The test specimens shall not be in direct contact with any other specimen in the mount. The recommended minimum distance between test specimens in a mount is 0.25 mm (.010 inch).
  - (2) The traceability requirements of [MIL-PRF-31032](#) shall apply.

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4.7.2.2 Microsection examination and inspection. Microsection examination and inspection shall be accomplished in accordance with test method number 2.2.5 of IPC-TM-650 to evaluate characteristics such as dielectric spacing, etchback, plating thickness, foil thickness, and so forth, in plated holes. If more than three plated holes are in a row on a test specimen, all holes in the row shall be evaluated. The following details shall apply:

- a. Magnifications. The specimens shall be inspected at magnifications specified in test method number 2.2.5 of IPC-TM-650. Referee inspections shall be accomplished at a magnification of 200X to 400X  $\pm$ 5 percent.
- b. Evaluations. The plated holes shall be evaluated for plating separations both prior to and after microetching. Pre- and post-microetching evaluations for the criteria of 3.1, 3.3, and 3.6 shall be accomplished at magnifications specified above.
- c. Measurements. Thickness measurements shall be averaged from at least three determinations for each side of the plated hole. Isolated thick or thin sections shall not be used for averaging; however, isolated areas of reduced copper thickness shall be measured and evaluated to the copper plating void rejection criteria specified in 3.6.3.2.1.

EXAMPLE: The copper plating thickness of the plated-through hole wall shall be determined from the average of three measurements, approximately equally spaced, taken on each side of the hole.

- d. Plating or coatings that are less than 0.00125 mm (.00005 inch) in thickness shall not be measured using metallographic techniques. See 4.7.1.3 for alternate measurement techniques.

4.7.3 Chemical test methods.

4.7.3.1 Ionic contamination. The printed board specimen shall be inspected for ionic contamination in accordance with test method number 2.3.25 of IPC-TM-650.

4.7.3.2 Elongation of copper. The test for elongation of copper shall be performed in accordance with test method number 2.4.18.1 of IPC-TM-650. The travel speed of testing shall be 50.0 mm  $\pm$ 1.0 mm (1.97  $\pm$ .03 inches) for each minute of test.

4.7.3.3 Tensile strength of copper. The test for tensile strength of copper shall be performed in accordance with test method number 2.4.18.1 of IPC-TM-650 with the following exceptions:

- a. The travel speed of testing shall be 50.0 mm  $\pm$ 1.0 mm (1.97  $\pm$ .03 inches) for each minute.
- b. The mean average cross-sectional area shall be calculated using the following steps:
  - (1) Measure the thickness of specimens by use of an optimizer (an electrical-type measuring device) or vernier micrometer, provided that the thickness is measured to at least the nearest 2 percent.
  - (2) Measure and record the specimen width dimension to the nearest 0.025 mm (.001 inch).
  - (3) The mean average cross-sectional area is the result of the average thickness multiplied by the average width.

4.7.4 Physical test methods.

4.7.4.1 Adhesion, marking. Test specimens which represent all types of marking used on the lot (except etched marking) shall be subjected to the solderability test in 4.7.4.7. The side of the test specimen that is marked shall be placed against the solder. After the test, the test specimen shall be examined in accordance with 4.7.1 and the requirements of 3.7.4.1 shall be met.

4.7.4.2 Adhesion, plating. The test for plating adhesion shall be performed in accordance with test method number 2.4.1 of IPC-TM-650.

4.7.4.3 Bow and twist. The tests for bow and twist shall be performed in accordance with test method number 2.4.22 of IPC-TM-650.

4.7.4.4 Flexibility endurance.

4.7.4.4.1 Qualification and periodic tests. The flexibility endurance test shall be in accordance with test method number 2.4.3 of IPC-TM-650. The flexibility endurance test may also be performed using an alternative method specified in 6.5.3. The following exceptions shall apply:

- a. Test specimen: Test specimens shall be production designs or test coupon in accordance with test method number 2.4.3 of IPC-TM-650.
- b. Number of flex cycles: 100,000.
- c. Diameter of mandrel: The diameter of the mandrel shall be twelve times the sum of the total ply thickness reduced to the nearest 2.50 mm (.098 inch).
- d. Flexing rate: 0.3 seconds for each cycle, minimum.
- e. Travel of loop (when applicable): 30.0 mm (1.18 inch) minimum.

4.7.4.4.2 Acquiring activity specified. The flexibility endurance test shall be in accordance with test method number 2.4.3 of IPC-TM-650. The following details shall be specified (see 6.2.1.c):

- a. Number of flex cycles.
- b. Diameter of mandrel.
- c. Flexing rate.
- d. The length of travel of loop.

4.7.4.5 Folding flexibility.

4.7.4.5.1 Qualification and periodic tests. The folding flexibility test shall be performed in accordance with 4.7.4.5.3 and figure 6.

4.7.4.5.2 Acquiring activity specified. The folding flexibility test shall be performed in accordance with 4.7.4.5.3 and figure 6. The following details shall be specified (see 6.2.1.c):

- a. Direction of bend (detail A in figure 6).
- b. Degree of bend (detail B in figure 6).
- c. Points of application (detail C in figure 6).
- d. Diameter of mandrel (detail D in figure 6): The diameter of mandrel shall be 12 times overall material thickness, reduced to the nearest 2.50 mm (.098 inch).
- e. Number of fold cycles.

4.7.4.5.3 Fold cycle. A fold cycle shall be defined as taking one end of the specimen and folding it around a mandrel and then unfold back to the original starting position, traveling 180 degrees in one direction and 180 degrees in the opposite direction. A fold cycle may also be defined as folding (using opposite ends) the ends toward each other (fold the same direction) and then unfold back to the original starting position, with each end traveling 90 degrees in one direction and 90 degrees in the opposite direction. The specified number of fold cycles shall be performed with the mandrel placed in contact with the specimen on one side and then again with the mandrel placed in contact with the specimen on the opposite side.

#### 4.7.4.6 Rework simulation.

4.7.4.6.1 Single and double sided without plated holes. The rework simulation test shall be performed in accordance with test method number 2.4.21 of IPC-TM-650.

4.7.4.6.2 Double sided with plated holes. The rework simulation test shall be performed in accordance with test method number 2.4.36 of IPC-TM-650.

4.7.4.7 Solderability. The tests for hole or surface solderability shall be performed in accordance with J-STD-003. When required by the procurement documentation, accelerated conditioning for coating durability shall be in accordance with J-STD-003. The default category of coating durability of J-STD-003 is category 2.

#### 4.7.5 Electrical test methods.

4.7.5.1 Continuity and isolation, production screening. Printed boards shall be electrical tested using either automatic or manual equipment capable of verifying the level C requirements of IPC-9252 for 100 percent continuity and isolation.

#### 4.7.5.2 Continuity and isolation, qualification and periodic testing.

4.7.5.2.1 Continuity. A current shall be passed through each conductor or group of interconnected conductors by applying electrodes on the terminals at each end of the conductor or group of conductors. The current passed through the conductors shall not exceed those specified in the applicable design standard for the smallest conductor in the circuit.

4.7.5.2.2 Isolation (circuit shorts). A test voltage shall be applied between all common portions of each conductor pattern and all adjacent common portions of each conductor pattern. The test voltage shall be applied between conductor patterns of each layer and the electrically isolated pattern of each adjacent layer (when applicable). For manual testing, the test voltage shall be 200 volts minimum and shall be applied for a minimum of 5 seconds. When automated test equipment is used, the minimum applied test voltage shall be the maximum rated voltage specified. If the maximum rated voltage on the printed board is not specified, the test voltage shall be 40 volts minimum.

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4.7.6 Environmental test methods.

4.7.6.1 Moisture and insulation resistance. The test for moisture and insulation resistance shall be performed in accordance with class 3 test conditions of test method number 2.6.3 of IPC-TM-650 using specimen preparation method A. The initial and final insulation resistance shall be greater than, or equal to, 500M ohm when measured at 500 volts (+10, -0 percent) dc.

4.7.6.2 Resistance to soldering heat.

4.7.6.2.1 Solder float thermal stress. The test for solder float thermal stress shall be performed in accordance with test condition A of appendix F of MIL-PRF-31032.

4.7.6.2.2 Convection air oven solder reflow thermal stress. The test for convection air oven solder reflow thermal stress shall be performed in accordance with test condition D of appendix F of MIL-PRF-31032.

4.7.6.3 Thermal shock. The test for thermal shock shall be performed in accordance with test method number 2.6.7.2 of IPC-TM-650 except that the temperature extremes shall be -65 degrees Celsius and +125 degrees Celsius for all coverlayer and flexible base material combinations and minimum dwell time at each temperature extreme shall be 15 minutes.

4.7.6.4 Temperature cycling.

4.7.6.4.1 DC current induced. The test for DC current induced thermal cycling shall be performed in accordance with test method number 2.6.26 of IPC-TM-650.

5. PACKAGING

5.1 Packaging. For acquisition purposes, the packaging requirements shall be as specified in the contract or order (see 6.2). When packaging of materiel is to be performed by DoD or in-house contractor personnel, these personnel need to contact the responsible packaging activity to ascertain packaging requirements. Packaging requirements are maintained by the Inventory Control Point's packaging activities within the Military Service or Defense Agency, or within the Military Service's system commands. Packaging data retrieval is available from the managing Military Department's or Defense Agency's automated packaging files, CD-ROM products, or by contacting the responsible packaging activity.

6. NOTES

(This section contains information of a general or explanatory nature that may be helpful, but is not mandatory.)

6.1 Notes. The notes specified in MIL-PRF-31032 are applicable to this specification.

6.1.1 Intended use. This specification sheet was developed for the use of verifying performance characteristics of flexible single or double sided (one or two conductor layers) printed wiring boards, with or without plated holes, that will use soldering for component/part mounting. Other single and double sided printed board technology types can be verified to the requirements contained in this document, however, the performance parameters and baseline verification methods of other performance specifications sheets may be more appropriate.

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6.2 Acquisition requirements. Acquisition documents should specify the following:

- a. Title, number, revision letter, and date of this specification.
- b. The specific issue of individual documents referenced (see section 2).
- c. Title, number, and date of applicable printed board procurement documentation or drawing. Identification of the originating design activity and, if applicable, the Government approved deviation list for the printed board procurement documentation or drawing.
- d. The complete product procurement documentation part or identifying number (see 3.1).
- e. The printed wiring board type (type 3 or 4, see 1.2.1 and 3.1) and installation use classification (use A or B, see 1.2.2 and 3.1).
- f. Title, number, revision letter (with amendment number when applicable), and date of the applicable design standard with performance classification.
- g. Requirements for delivery of one copy of the quality conformance inspection data pertinent to the product inspection lot to be supplied with each shipment by the QML manufacturer, if applicable.
- h. Requirements for certificate of compliance, if applicable.
- i. Requirements for notification of change of product or process to the contracting activity in addition to notification to the qualifying activity, if applicable.
- j. Packaging required (see 5.1).
- k. If special or additional identification marking is required (see 3.8).

6.2.1 Optional acquisition data. The following items are optional and are only applicable when specified in the printed board procurement documentation.

- a. Special or additional cleanliness is required (see 3.7.3.1 and 6.5.1).
- b. Special requirements for bow and twist (see 3.7.4.3 and 6.5.2).
- c. Special requirements for flex endurance (see 3.7.4.4).
- d. Special requirements for folding flexibility (see 3.7.4.5).
- e. The durability of coating rating (accelerated aging for solderability testing) if other than category 2 (see J-STD-003).
- f. Special requirements for electrical testing at the assembly level (see table I, footnote 5).
- g. Disposition of lot conformance inspection sample units.
- h. Requirements for failure analysis, corrective action and reporting of results.
- i. Any other additional special requirements.

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6.3 Qualification. With respect to products requiring qualification, awards will be made only for products which are, at the time of award of contract, qualified for inclusion in Qualified Manufacturers List (QML-31032) whether or not such products have actually been so listed by that date. The attention of the contractors is called to these requirements, and manufacturers are urged to arrange to have the products that they propose to offer to the Federal Government tested for qualification in order that they may be eligible to be awarded contracts or orders for the products covered by this specification. Information pertaining to qualification of products may be obtained from DLA Land and Maritime, ATTN: VQE, P.O. Box 3990, Columbus, OH 43218-3990 or e-mail [5998.Qualifications@dla.mil](mailto:5998.Qualifications@dla.mil) or at URL [http://www.landandmaritime.dla.mil/offices/sourcing\\_and\\_qualification/Offices](http://www.landandmaritime.dla.mil/offices/sourcing_and_qualification/Offices). An online listing of products qualified to this specification may be found in the Qualified Products Database (QPD) at <https://assist.dla.mil>.

6.4 Replacement information. This specification includes a majority of the performance requirements of previous revisions of MIL-P-50884 for types 1 and 2 printed wiring boards. Printed wiring boards conforming to this specification sheet would be comparable to printed wiring boards conforming to MIL-P-50884.

6.5 Notes regarding optional verification testing.

6.5.1 Ionic contamination (cleanliness). This optional verification test is listed in [table I](#), lot conformance inspection. If verification is required, the acquiring activity should specify acceptability requirements and test specimen sampling frequency.

6.5.2 Bow and twist. This optional verification test is listed in [table I](#), lot conformance inspection. If verification is required, the acquiring activity should specify acceptability requirements and test specimen sampling frequency.

6.5.3 Flexibility endurance. The flexibility endurance test may be performed using test method number [2.4.3.1 of IPC-TM-650](#).

6.6 Stiffener adhesion test and requirement. This document does not include the stiffener adhesion test or requirement contained in MIL-P-50884. All stiffeners are viewed as a mechanical support and total bonding of the stiffener to the printed board is not required for compliance with this document.

6.7 Tin finishes and whisker growth. Use of tin plating or coating is prohibited (see [3.4.1](#)). The use of alloys with tin content greater than 97 percent, by mass, may exhibit tin whisker growth problems after manufacture. Tin whiskers may occur anytime from a day to years after manufacture and can develop under typical operating conditions on products that use such materials. Conformal coatings applied over top of a whisker-prone surface will not prevent the formation of tin whiskers. Alloys containing at least 3 percent lead, by mass, have shown to inhibit the growth of tin whiskers. For additional information on this matter, refer to ASTM B545 (Standard Specification for Electrodeposited Coating of Tin).

6.8 Amendment notations. The margins of this specification are marked with vertical lines to indicate modifications generated by this amendment. This was done as a convenience only and the Government assumes no liability whatsoever for any inaccuracies in these notations. Bidders and contractors are cautioned to evaluate the requirements of this document based on the entire content irrespective of the marginal notations and relationship to the last previous issue.

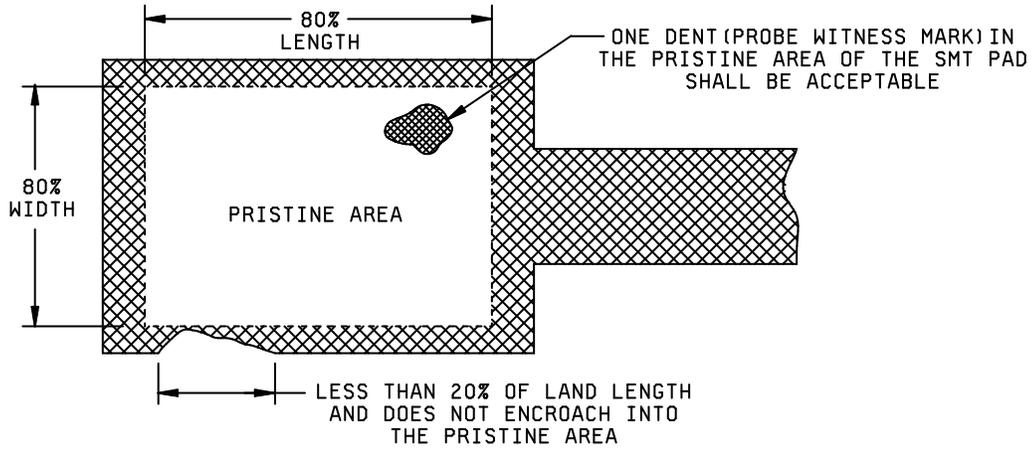


FIGURE 1. Rectangular surface mount lands.

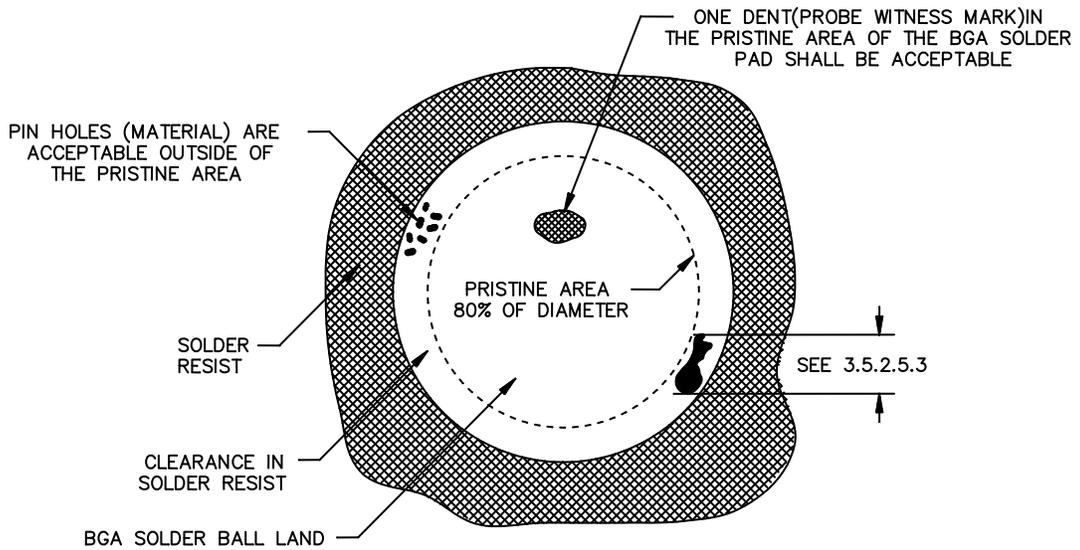


FIGURE 2. Round surface mount lands (BGA pads).

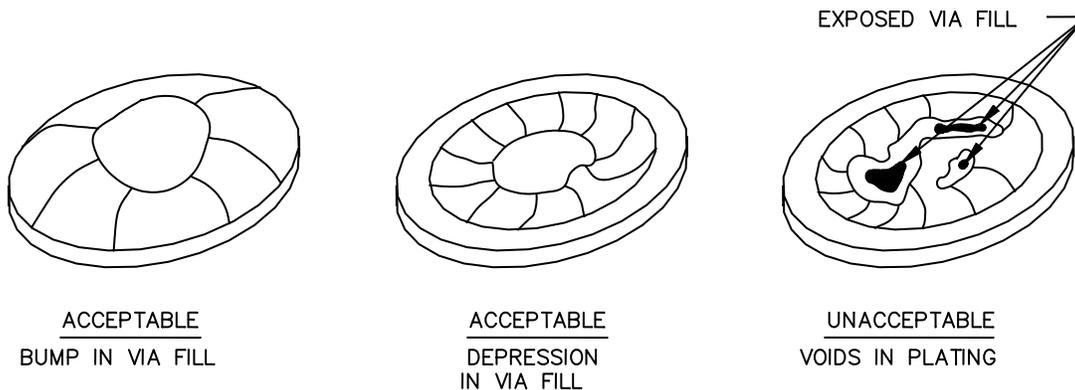


FIGURE 3. Via copper cap plating deviations.

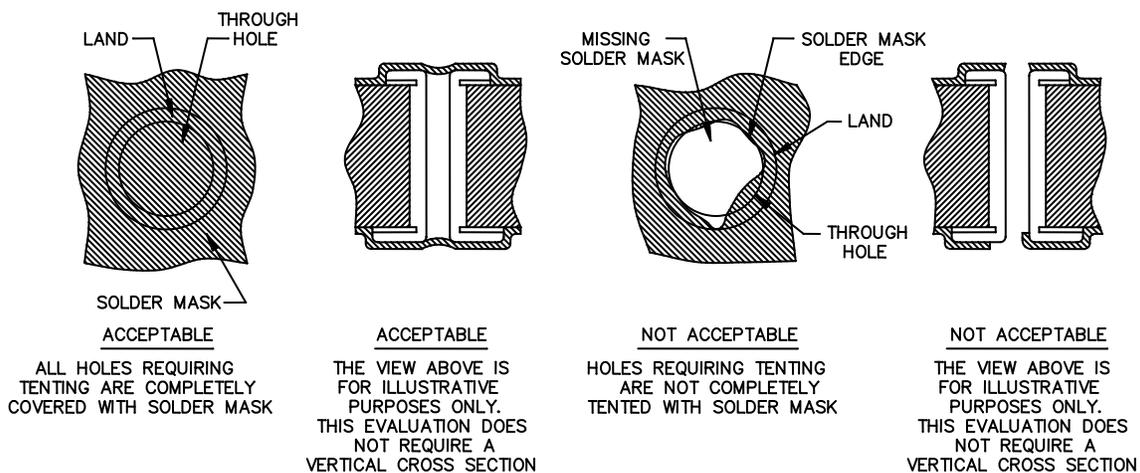
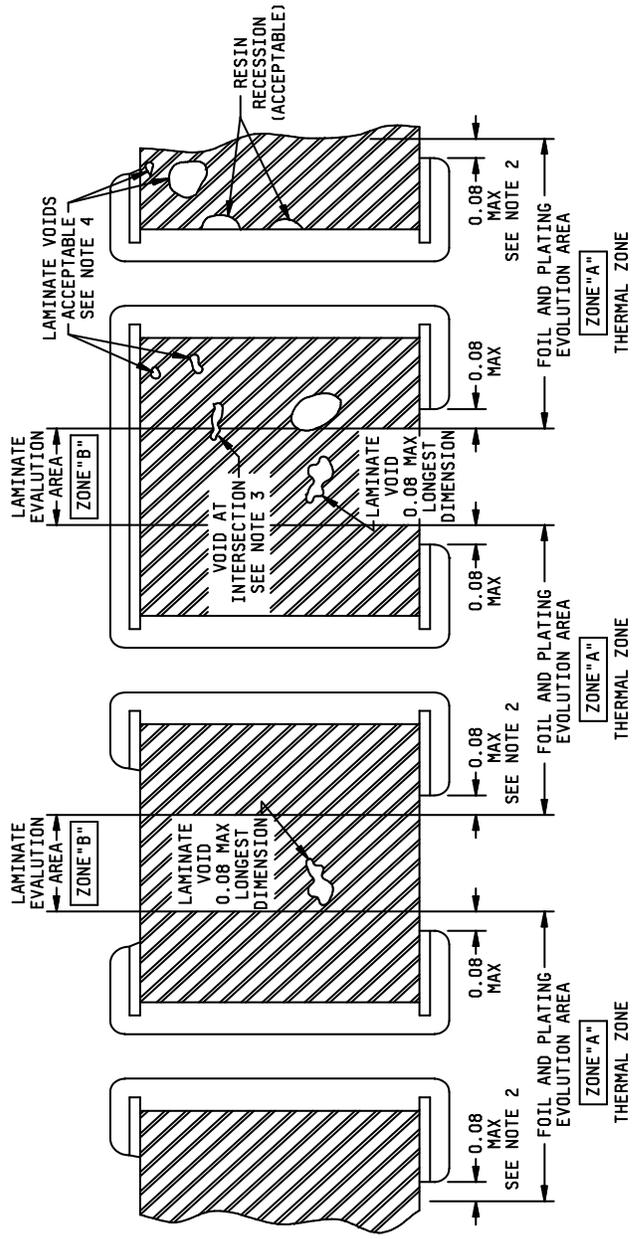


FIGURE 4. Solder mask tenting deviations.



- NOTES:
1. Dimensions are in millimeters.
  2. Typically beyond land edge most radially extended.
  3. Voids at intersection of zone A and zone B. Laminate voids greater than 0.08 (.003 inch) that extend into zone B are rejectable.
  4. Laminate voids are not evaluated in zone A.

FIGURE 5. Typical plated-through hole cross section after resistance to soldering heat or rework simulation.

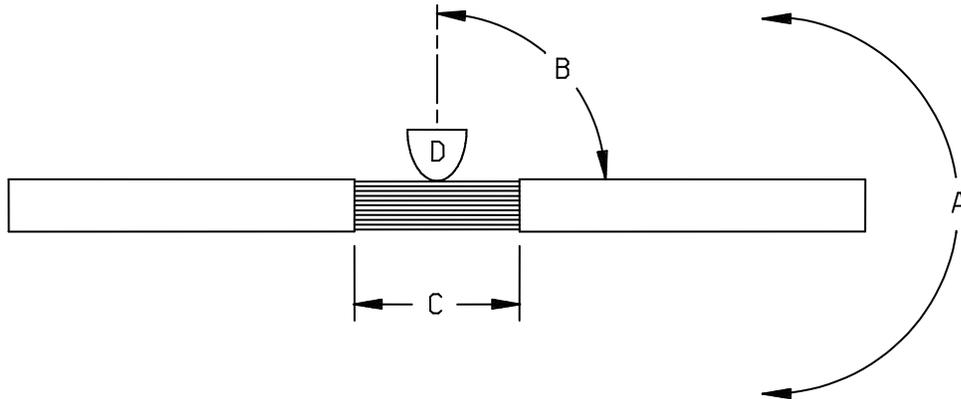


FIGURE 6. Folding flexibility test.

Custodians:  
Army – CR  
Navy – EC  
Air Force – 85  
DLA – CC

Preparing activity:  
DLA – CC  
  
(Project 5998–2012–063)

Review activities:  
Army – AV, MI  
Navy – CG  
Air Force – 99

NOTE: The activities listed above were interested in this document as of the date of this document. Since organizations and responsibilities can change, you should verify the currency of the information above using the ASSIST Online database at <https://assist.dla.mil>.